

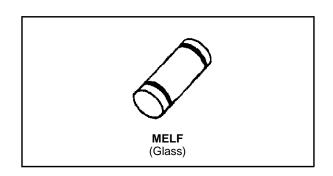
# **TMBAT 49**

## SMALL SIGNAL SCHOTTKY DIODE



General purpose metal to silicon diode featuring very low turn-on voltage and fast switching.

This device has integrated protection against excessive voltage such as electrostatic discharges.



## **ABSOLUTE MAXIMUM RATINGS** (limiting values)

| Symbol            | Parameter  |   | Value                          | Unit |
|-------------------|--|---|--------------------------------|------|
| $V_{RRM}$         | Repetitive Peak Reverse Voltage                            |   | 80                             | V    |
| l <sub>F</sub>    | Forward Continuous Current                                 | ard Continuous Current $T_i = 70  ^{\circ}\text{C}$ |                                | mA   |
| I <sub>FRM</sub>  | Repetitive Peak Forward Current                            | $tp = 1s$ $\delta \le 0.5$                          | 3                              | А    |
| I <sub>FSM</sub>  | Surge non Repetitive Forward Current t <sub>p</sub> = 10ms |   | 10                             | А    |
| $T_{stg} \ T_{j}$ | Storage and Junction Temperature Range                     |   | - 65 to + 150<br>- 65 to + 125 | °C   |
| TL                | Maximum Temperature for Soldering during 15s               |   | 260                            | °C   |

#### THERMAL RESISTANCE

| Symbol               | Test Conditions | Value | Unit |
|----------------------|-----------------|-------|------|
| R <sub>th(j-l)</sub> | Junction-leads  | 110   | °C/W |

## **ELECTRICAL CHARACTERISTICS**

## STATIC CHARACTERISTICS

| Symbol           | Test Conditions                           | Min. | Тур. | Max. | Unit |
|------------------|---|------|------|------|------|
| I <sub>R</sub> * | $T_j = 25^{\circ}C$ VR = 80V              |      |      | 200  | μΑ   |
| V <sub>F</sub> * | $T_j = 25^{\circ}C$ $I_F = 10\text{mA}$   |      |      | 0.32 | V    |
|                  | $T_j = 25^{\circ}C$ $I_F = 100 \text{mA}$ |      |      | 0.42 |      |
|                  | $T_j = 25^{\circ}C$ $I_F = 1A$            |      |      | 1    |      |

## DYNAMIC CHARACTERISTICS

| Symbol | Test Conditions       |          |                     | Min. | Тур. | Max. | Unit |
|--------|-----------------------|----------|---------------------|------|------|------|------|
| С      | T <sub>j</sub> = 25°C | f = 1MHz | $V_R = 0V$          |      | 120  |      | pF   |
|        |                       |          | V <sub>R</sub> = 5V |      | 35   |      |      |

<sup>\*</sup> Pulse test:  $t_p \le 300 \mu s \ \delta < 2\%$ .

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Figure 1. Forward current versus forward voltage at low level (typical values).

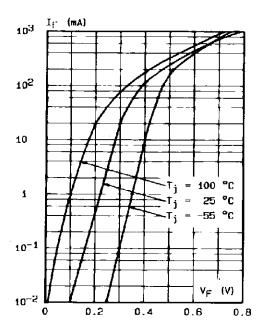


Figure 2. Forward current versus forward voltage at high level (typical values).

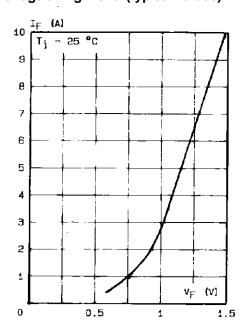


Figure 3. Reverse current versus junction temperature.

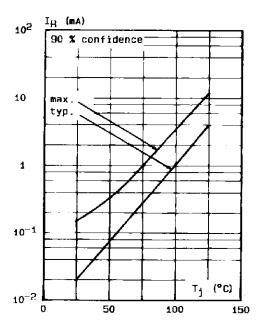


Figure 4. Reverse current versus  $V_{\mbox{\scriptsize RRM}}$  in per cent.

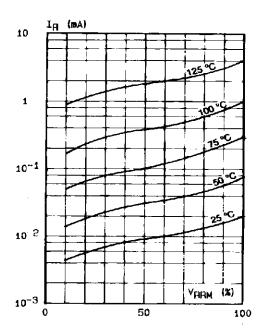


Figure 5. Capacitance C versus reverse applied voltage  $V_{\mbox{\scriptsize R}}$  (typical values).

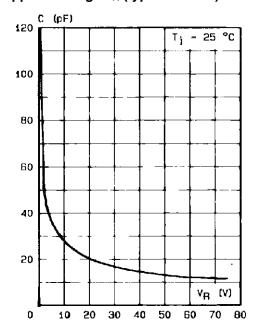


Figure 6. Surge non repetitive forward current for a rectangular pulse with  $t \le 10 \text{ ms}$ .

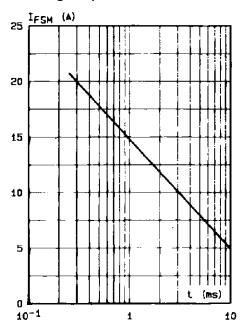
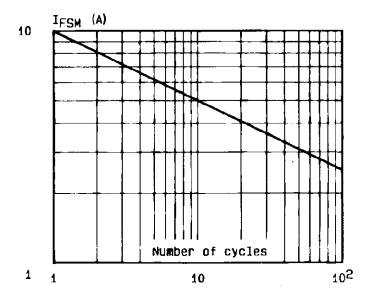
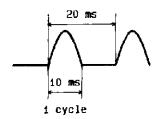


Figure 7. - Surge non repetitive forward current versus number of cycles.

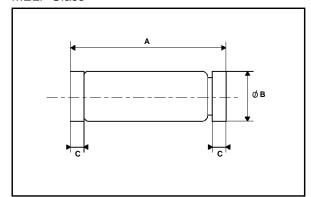




## **PACKAGE MECHANICAL DATA**

## **FOOT PRINT DIMENSIONS** (Millimeter)

#### **MELF Glass**



|   |             |            | <b>↑</b>     |
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|      | DIMENSIONS  |      |        |      |  |  |
|------|-------------|------|--------|------|--|--|
| REF. | Millimeters |      | Inches |      |  |  |
|      | Min.        | Max. | Min.   | Max. |  |  |
| Α    | 4.80        | 5.20 | 0.19   | 0.20 |  |  |
| В    | 2.55        | 2.65 | 0.10   | 0.10 |  |  |
| С    | 0.45        | 0.55 | 0.02   | 0.02 |  |  |

Marking: ring at cathode end. Weight: 0.15g

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